

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/944,454	FUKUSHIMA ET AL.	
Examiner		Art Unit	Craig W Kronenthal	
		2623	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,639,996	10-2003	Suda, Hirofumi	382/100
	B	US-6,208,745	03-2001	Florencio et al.	382/100
	C	US-2001/0010707 A1	08-2001	Matsumura et al.	375/240.24
	D	US-6,154,571	11-2000	Cox et al.	382/250
	E	US-6,298,142	10-2001	Nakano et al.	382/100
	F	US-2002/0009209 A1	01-2002	Inoue et al.	382/100
	G	US-6,553,127	04-2003	Kurowski, Kordian	382/100
	H	US-6,246,802	06-2001	Fujihara et al.	382/276
	I	US-2002/0012446 A1	01-2002	Tanaka, Nobuyuki	382/100
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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